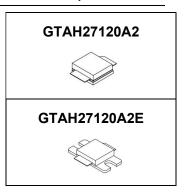
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### Gallium Nitride 28V 120W, RF Power Transistor

#### **Description**

The GTAH27120A2 is a 120W internally matched, GaN HEMT, designed for multiple application especially MC-GSM/WCDMA/LTE, from 700 to 2700MHz

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.



•Typical performance (on wide band fixture with device soldered)

 $V_{DD}$ =28V  $I_{DQ}$ =1200mA, Test signal: WCDMA, 3GPP test model 1; 1 to 64 DPCH; Channel Bandwidth=3.84MHz,PAR =10.5 dB at 0.01 % probability on CCDF.

Frequency (MHz)	$P_{L(AV)}(W)$	Gp (dB)	η <sub>D</sub> (%)	ACPR <sub>5M</sub> (dBc)
1800	10	16.9	22.0	-42.4
1900	10	17. 7	21.6	-41.5
2000	10	18.8	22.9	-41.2
2100	10	18.8	21.5	-41.3
2200	10	18.3	22.0	-40.6
2300	10	18.0	21.3	-41.7
2400	10	17.8	20.1	-43.2
2500	10	18.3	20.3	-41.2
2600	10	18.3	21.1	-40.4
2700	10	17.4	23.5	-40.1

•Typical performance (on narrow band fixture with device soldered)

 $V_{DD}$ =32V  $I_{DQ}$ =340mA, CW.

Frequency(MHz)	Gp (dB)	P <sub>SAT</sub> (W)	Efficiency (%)
2400	16.2	181	63
2450	16.5	174	64
2500	16.4	165	65

#### **Applications and Features**

- Suitable for wireless communication infrastructure, wideband amplifier, EMC testing, ISM etc.
- High Efficiency and Linear Gain Operations
- Thermally Enhanced Industry Standard Package
- · High Reliability Metallization Process
- · Excellent thermal Stability and Excellent Ruggedness
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

#### **Important Note: Proper Biasing Sequence for GaN HEMT Transistors**

#### Turning the device ON

- 1. Set VGS to the pinch--off (VP) voltage, typically -5 V
- 2. Turn on VDS to nominal supply voltage (28V)
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

#### Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS



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#### **Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
DrainSource Voltage	V <sub>DSS</sub>	150	Vdc
GateSource Voltage	V <sub>GS</sub>	-10,+2	Vdc
Operating Voltage	V <sub>DD</sub>	40	Vdc
Maximum Forward Gate Current @ Tc = 25°C	Igmax	27	mA
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	Tc	+150	°C
Operating Junction Temperature(See not2 1)	T <sub>J</sub>	+200	°C
Total Device Power Dissipation (Derated above 25°C, see note 2)	Pdiss	125	w

Note: 1. Continuous operation at maximum junction temperature will affect MTTF

#### **Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit	
Thermal Resistance, Junction to Case	Doug	1.44	C/W	
T <sub>C</sub> = 85°C, T <sub>J</sub> =200°C, RF CW operation	R⊕JC	1.44	C/ VV	

#### Table 3. Electrical Characteristics ( $T_C = 25^{\circ}C$ unless otherwise noted)

#### **DC Characteristics**

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	V <sub>GS</sub> =-8V; I <sub>DS</sub> =27mA	V <sub>DSS</sub>	150			V
Gate Threshold Voltage	V <sub>DS</sub> = 28V, I <sub>D</sub> = 27mA	V <sub>GS</sub> (th)		-2.7		V
Gate Quiescent Voltage	V <sub>DS</sub> =28V, I <sub>DS</sub> =1200mA, Measured in Functional Test	$V_{GS(Q)}$		-2.31		V

Functional Tests (In 2.3-2.7GHz Production fixture, 50 ohm system) :  $V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 1200 \text{ mA}$ , f = 2500 MHz, WCDMA signal,

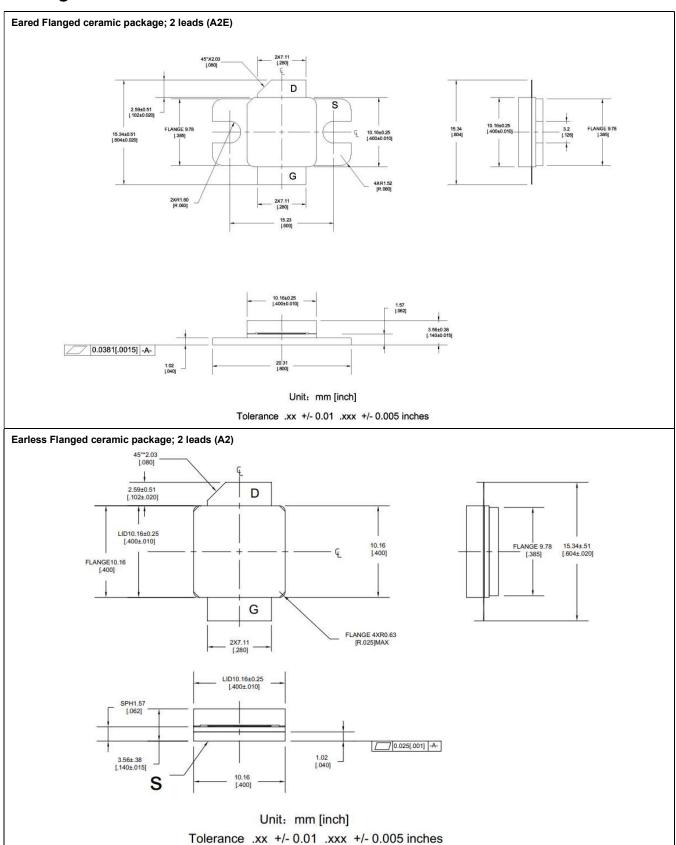
#### Pout=24W

Characteristic	Symbol	Min	Тур	Max	Unit
Power Gain	Gp		17		dB
Drain Efficiency @ Pout	Eff		37		%
Saturated Power by CCDF test	P <sub>SAT</sub>	120			W
Input Return Loss	IRL		-7		dB
Mismatch stress at all phases (Device no damage)	VSWR		10:1		Ψ

<sup>2.</sup>Bias Conditions should also satisfy the following expression: Pdiss < (Tj - Tc) / RJC and Tc = Tcase

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## **Package Outline**



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### **Revision history**

**Table 4. Document revision history** 

Date	Revision	Datasheet Status
2017/5/27	V1.0	Preliminary Datasheet Creation
2017/6/20	V1.1	Maximum rating modified, function test condition modified
2017/7/27	V1.2	Maximum rating modified, function test data modified
2020/6/19	V1.3	Update on lower frequency limits

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